

## NTE2365 Silicon NPN Transistor High Voltage Horizontal Deflection Output

**Features:**

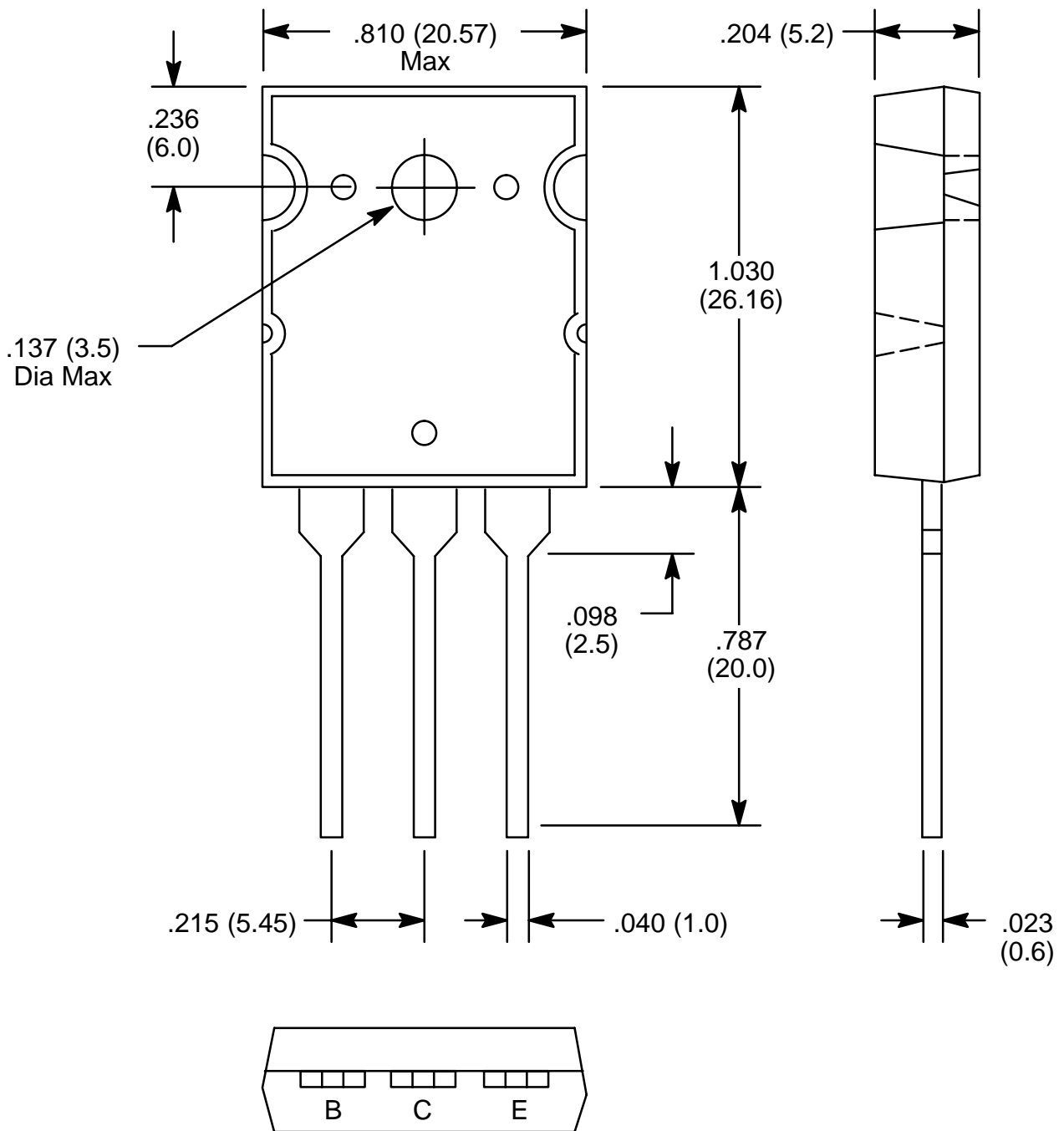
- High Speed:  $t_f = 100\text{ns typ}$
- High Reliability
- High Breakdown Voltage:  $V_{CBO} = 1500\text{V}$

**Absolute Maximum Ratings:** ( $T_A = +25^\circ\text{C}$  unless otherwise specified)

Collector to Base Voltage, $V_{CBO}$ .....	1500V
Collector to Emitter Voltage, $V_{CEO}$ .....	800V
Emitter to Base Voltage, $V_{EBO}$ .....	6V
Collector Current, $I_C$	
Continuous .....	12A
Peak .....	30A
Collector Dissipation, $P_C$ .....	180W
Junction Temperature, $T_J$ .....	+150°C
Storage Temperature Range, $T_{stg}$ .....	-55° to +150°C

**Electrical Characteristics:** ( $T_A = +25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector Cutoff Current	$I_{CBO}$	$V_{CB} = 800\text{V}, I_E = 0$	–	–	10	$\mu\text{A}$
	$I_{CES}$	$V_{CE} = 1500\text{V}, R_{BE} = 0$	–	–	1.0	mA
Collector Sustaining Voltage	$V_{CEO(sus)}$	$I_C = 100\text{mA}, I_B = 0$	800	–	–	V
Emitter Cutoff Current	$I_{EBO}$	$V_{EB} = 4\text{V}, I_C = 0$	–	–	1.0	mA
Collector–Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{A}, I_B = 2.5\text{A}$	–	–	5	V
Base–Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 10\text{A}, I_B = 2.5\text{A}$	–	–	1.5	V
DC Current Gain	$h_{FE(1)}$	$V_{CE} = 5\text{V}, I_C = 1\text{A}$	8	–	30	
	$h_{FE(2)}$	$V_{CE} = 5\text{V}, I_C = 10\text{A}$	4	–	8	
Storage Time	$t_{stg}$	$I_C = 8\text{A}, I_{B1} = 1.6\text{A}, I_{B2} = -3.2\text{A}$	–	–	3.0	$\mu\text{s}$
Fall Time	$t_f$		–	–	0.2	$\mu\text{s}$



**Note:** Pin2 connected to metal part of mounting surface.